PROCEEDINGS OF SPIE

Quantum Dots and Nanostructures: Synthesis, Characterization, and Modeling IX

Kurt G. Eyink Frank Szmulowicz Diana L. Huffaker Editors

24–25 January 2012 San Francisco, California, United States

Sponsored and Published by SPIE

Volume 8271

The papers included in this volume were part of the technical conference cited on the cover and title page. Papers were selected and subject to review by the editors and conference program committee. Some conference presentations may not be available for publication. The papers published in these proceedings reflect the work and thoughts of the authors and are published herein as submitted. The publisher is not responsible for the validity of the information or for any outcomes resulting from reliance thereon.

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Author(s), "Title of Paper," in Quantum Dots and Nanostructures: Synthesis, Characterization, and Modeling IX, edited by Kurt G. Eyink, Frank Szmulowicz, Diana L. Huffaker, Proceedings of SPIE Vol. 8271 (SPIE, Bellingham, WA, 2012) Article CID Number.

ISSN 0277-786X ISBN 9780819489142

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445 SPIE.org

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Printed in the United States of America.

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Contents

- v Conference Committee
- vii Spinoptics: Spin degeneracy removal in nanostructures (Plenary Paper) [8269-100] V. Kleiner, N. Shitrit, E. Hasman, Technion-Israel Institute of Technology (Israel)

SESSION 1 HYBRID STRUCTURES

8271 04 Effect of silver nanoparticles on the spectral properties of rare-earth ions in a sodium borate glass [8271-03]

V. O. Obadina, B. Rami Reddy, Alabama A&M Univ. (United States)

8271 06 Optical properties of mesogen-coated gold nanoparticles [8271-05]

J. Dintinger, Ecole Polytechnique Fédérale de Lausanne (Switzerland); B.-J. Tang, The Univ. of Hull (United Kingdom); X. Zeng, The Univ. of Sheffield (United Kingdom); T. Kienzler, Friedrich-Schiller-Univ. Jena (Germany); G. H. Mehl, The Univ. of Hull (United Kingdom); G. Ungar, C. Rockstuhl, The Univ. of Sheffield (United Kingdom); T. Scharf, Friedrich-Schiller-Univ. Jena (Germany)

SESSION 2 COLLODIAL QUANTUM DOTS

- 8271 08 Morphology, optical properties, charge transfer, and charge transport in nanocrystalline quantum dots (Invited Paper) [8271-08]
 - S. Biswas, H. Jung, M. Stroscio, M. Dutta, Univ. of Illinois at Chicago (United States)
- 8271 09 Transport properties of mid-infrared colloidal quantum dot films [8271-09]

E. Lhuillier, S. Keuleyan, P. Guyot-Sionnest, The Univ. of Chicago (United States)

8271 0A Fourier spectroscopy on PbS quantum dots [8271-10]

B. Ullrich, J. S. Wang, X. Y. Xiao, G. J. Brown, Air Force Research Lab. (United States)

SESSION 3 OPTICAL DEVICES I

8271 0D Single photon sources for quantum information applications (Invited Paper) [8271-13]

S. Höfling, C. Schneider, T. Heindel, M. Lermer, Julius-Maximilians-Univ. Würzburg (Germany); T. B. Hoang, Technische Univ. Eindhoven (Netherlands); J. Beetz, T. Braun, Julius-Maximilians-Univ. Würzburg (Germany); L. Balet, Technische Univ. Eindhoven (Netherlands) and Ecole Polytechnique Fédérale de Lausanne (Switzerland); N. Chauvin, Technische Univ. Eindhoven (Netherlands); L. Li, Ecole Polytechnique Fédérale de Lausanne (Switzerland); S. Reitzenstein, Julius-Maximilians-Univ. Würzburg (Germany); A. Fiore, Technische Univ. Eindhoven (Netherlands); M. Kamp, A. Forchel, Julius-Maximilians-Univ. Würzburg (Germany)

8271 0E Reducing dephasing in coupled quantum dot-cavity systems by engineering the carrier wavefunctions [8271-14]

A. Nysteen, P. Kaer, J. Mørk, Technical Univ. of Denmark (Denmark)

SESSION 4	NOVEL MATERIALS
8271 01	Evolution of micro-spikes on silicon surface etched by femtosecond laser with different fabrication conditions (Invited Paper) [8271-18] Y. Peng, Y. M. Zhu, Univ. of Shanghai for Science and Technology (China)
8271 OJ	Hyperspectral polarized light scattering for dense nanomaterials characterization [8271-19] R. Ceolato, N. Riviere, L. Hespel, ONERA (France); B. Biscans, CNRS-LGC (France)
SESSION 5	GROWTH AND CHARACTERIZATION
8271 OL	Semiconductor quantum nanostructures by droplet epitaxy (Invited Paper) [8271-21] S. Sanguinetti, S. Bietti, C. Somaschini, Univ. degli Studi di Milano-Bicocca (Italy)
8271 ON	The impact of growth rate and barrier thickness on the thermal stability of photoluminescence for coupled InAs/GaAs quantum dot heterostructures with quaternary(InAlGaAs) capping [8271-23] A. Mandal, Indian Institute of Technology Bombay (India); U. Verma, Indian Institute of Technology Rajasthan (India); S. Chakrabarti, Indian Institute of Technology Bombay (India)
8271 00	Ground state energy trend in single and multilayered coupled InAs/GaAs QDs capped with InGaAs layers: effect of thickness of InGaAs layer and the RTA treatment [8271-24] S. Jejurikar, A. Mishra, P. Bhat, S. Chakrabarti, Indian Institute of Technology Bombay (India)
8271 OR	Increase in photoluminescence intensity of InAs columnar quantum dots on InP(001) substrate by increasing indium and phosphorous composition in InGaAsP barrier layers [8271-27] S. Okumura, N. Yasuoka, Photonics Electronics Technology Research Association (Japan) and Fujitsu Ltd. (Japan); K. Kawaguchi, Fujitsu Labs., Ltd. (Japan); Y. Tanaka, Photonics Electronics Technology Research Association (Japan) and Fujitsu Ltd. (Japan); M. Ekawa, Fujitsu Labs., Ltd. (Japan)
SESSION 6	OPTICAL DEVICES II
8271 OS	Improvement of temperature stability in columnar quantum dots by introducing side barriers with larger bandgap energy for semiconductor optical amplifiers [8271-29] N. Yasuoka, S. Okumura, Fujitsu Labs., Ltd. (Japan) and Photonics Electronics Technology Research Association (Japan); H. Ebe, Fujitsu Labs., Ltd. (Japan); Y. Tanaka, Fujitsu Labs., Ltd. (Japan) and Photonics Electronics Technology Research Association (Japan); M. Ekawa, Y. Nakata, Fujitsu Labs., Ltd. (Japan); M. Sugawara, QD Laser Inc. (Japan); Y. Arakawa, Institute for Nano Quantum Information Electronics (Japan) and The Univ. of Tokyo (Japan)
8271 OV	Computational analysis of the effects of gain material inclusion in engineered metal
327 I UV	nanostructures [8271-06] J. Duan, Air Force Research Lab. (United States) and General Dynamics Information Technology (United States); R. Pachter, Air Force Research Lab. (United States)
	Author Index

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 Jian Xu, The Pennsylvania State University (United States)

- Growth and CharacterizationGregory J. Salamo, University of Arkansas (United States)
- 6 Optical Devices II **Baolai Liang**, University of California, Los Angeles (United States)